N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0045 at V _{GS} = 10 V	72	33 nC			
30	0.0075 at V _{GS} = 4.5 V	56	33 110			

FEATURES

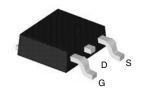
- DT-Trench Power MOSFET
- 100 % Rg and UIS Tested
- PWM Optimized

APPLICATIONS

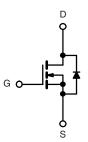
- LCD Display Backlight Inverters
- DC/DC Converters



TO-252 Pin Configuration



Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	30	V			
Gate-Source Voltage		V_{GS}	± 20	V		
	T _C = 25 °C		72 ^a			
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I_	56			
Continuous Diam Current (1) = 130 C)	T _A = 25 °C	I _D	29 ^b			
	T _A = 70 °C		19 ^b	А		
Pulsed Drain Current	I _{DM}	310				
Continuous Source-Drain Diode Current	T _C = 25 °C	1	72			
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	4.3 ^b			
Single Pulse Avalanche Current L = 0.1 mH		I _{AS}	70			
Avalanche Energy	L = 0.1 IIII1	E _{AS}	160	mJ		
	T _C = 25 °C		179	W		
Maximum Power Dissipation	T _C = 70 °C	P _D	114			
Maximum Fower Dissipation	T _A = 25 °C	- FD	6.1 ^b			
	T _A = 70 °C		3.9 ^b			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	18	23	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.2	1.8	O/VV	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 10 mA		44		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 1.0 mA		- 5.9			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zara Cata Valtaga Drain Current	I _{DSS}	V _{DS} = 24 V, V _{GS} = 0 V			1	1 20 μA	
Zero Gate Voltage Drain Current		V _{DS} = 24 V, V _{GS} = 0 V, T _J = 70 °C			20		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	72			Α	
Drain-Source On-State Resistance ^a	В	V _{GS} = 10 V, I _D = 20 A		0.0045	0.0055	Ω	
Diain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 15 A		0.0075	0.0090	22	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		85		S	
Dynamic ^b							
Input Capacitance	C _{iss}			3170		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		305			
Reverse Transfer Capacitance	C _{rss}			73			
Total Cata Charge	Q _g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		33			
Total Gate Charge				18		nC	
Gate-Source Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 15 \text{ A}$		6.6			
Gate-Drain Charge	Q_{gd}			4.1			
Gate Resistance	R_g	f = 1 MHz		2.5		Ω	
Turn-On Delay Time	t _{d(on)}			35			
Rise Time	t _r	V_{DD} = 15 V, R_L = 1 Ω		16			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 15 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		43			
Fall Time	t _f			11		no	
Turn-On Delay Time	t _{d(on)}			13		ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 1 \Omega$		6			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		32			
Fall Time	t _f			7			
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			72	Α	
Pulse Diode Forward Current ^a	I _{SM}				310	A	
Body Diode Voltage	V_{SD}	I _S = 10 A		0.7	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			26	37	ns	
Body Diode Reverse Recovery Charge C		L = 20 A dl/dt = 100 A/vs T = 05 °C		15	23	nC	
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		11			
Reverse Recovery Rise Time	t _b			10		ns	

Notes:

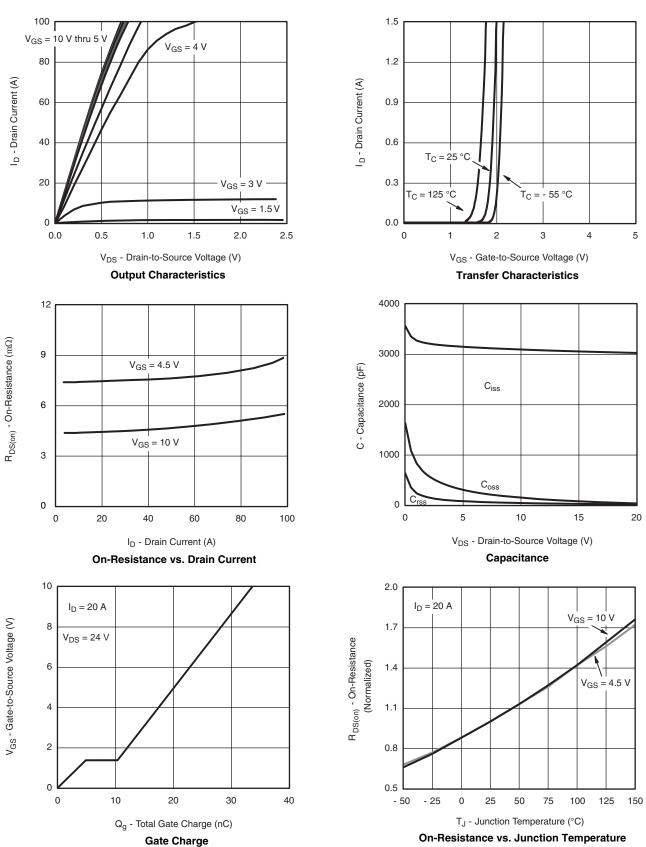
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

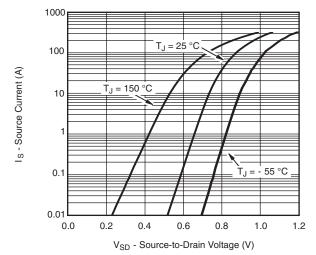


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

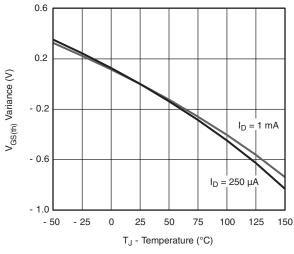




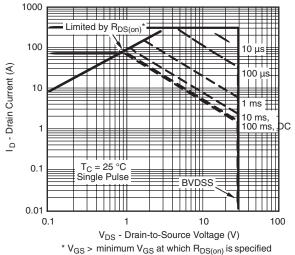




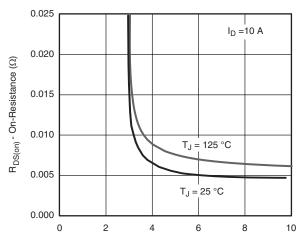
Source-Drain Diode Forward Voltage



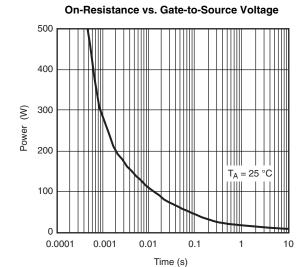
Threshold Voltage



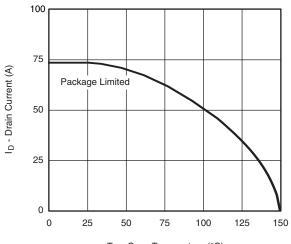
Safe Operating Area, Junction-to-Case



 $V_{\mbox{\footnotesize GS}}$ - Gate-to-Source Voltage (V)



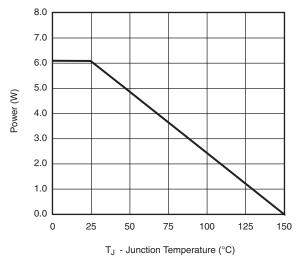
Single Pulse, Junction-to-Ambient

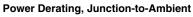


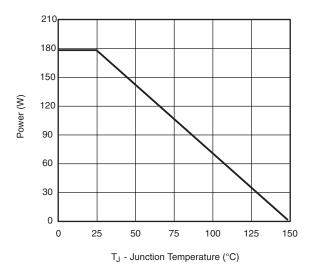
T_C - Case Temperature (°C)

Current Derating*, Junction-to-Case

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





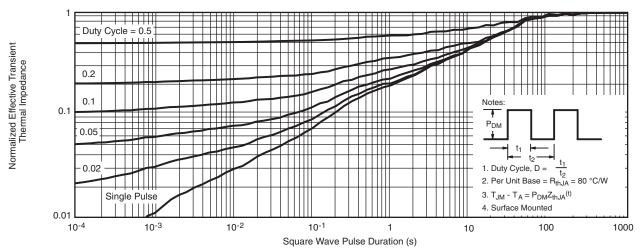


Power Derating, Junction-to-Case

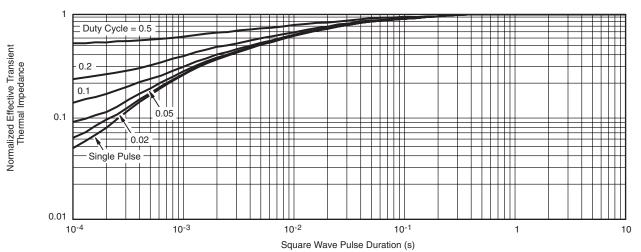
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



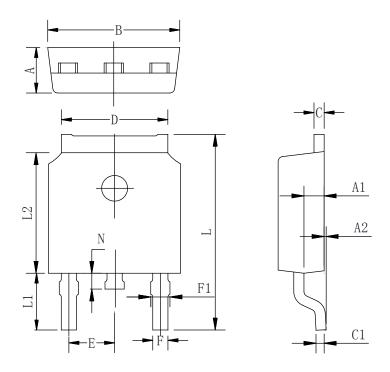
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-252-2L PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Тур	Max	
A	2.10	2.30	2.50	
A1	0.88	1.01	1.16	
A2	0.00	0.15	0.28	
В	6.40	6.60	6.80	
С	0.42	0.50	0.63	
C1	0.42	0.50	0.63	
D	5.08	5.32	5.65	
Е	2.286 TYP			
F	0.63	0.76	0.89	
F1	0.64	0.86	1.08	
L	9.30	9.90	10.80	
L1	2.4	2.8	3.6	
L2	5.90	6.10	6.55	
N	0.57	0.80	1.05	





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